Application/Control No.	Applicant(s)/Patent under Reexamination		
10/829,373	YAMAOKA ET AL.		
Examiner	Art Unit		
Hai H. Huvnh	3747		

SEARCHED					
Class	Subclass	Date	Examiner		
123	295	8/31/2005	ннн		
123	305	8/31/2005	ннн		
123	90.11	8/31/2005	ннн		
123	90.15	8/31/2005	ннн		
123	90.16	8/31/2005	ннн		
123	435	8/31/2005	ннн		
123	436	8/31/2005	ннн		
123	568.14	8/31/2005	ннн		
477	111	8/31/2005	ннн		
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INTERFERENCE SEARCHED					
Subclass	Date	Examiner			
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
East .	8/31/2005	ннн		
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